Notice of References Cited

Application/Control No. 10/705,388	Reexamination	Applicant(s)/Patent Under Reexamination KEETH ET AL.		
Examiner	Art Unit			
Viet Q Nguyen	2818	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,732,041	03-1998	Joffe, Alexander	365/230.05
	В	US-6,781,590	08-2004	Katsura et al.	345/538
	С	US-5,831,924	11-1998	Nitta et al.	365/230.03
	D	US-6,683,814	01-2004	Keeth et al.	365/221
	E	US-6,690,609	02-2004	Keeth et al.	365/221
	F	US-6,693,836	02-2004	Keeth et al.	365/221
	G	US-6,665,223	12-2003	Keeth et al	365/220
	Н	US-6,515,914	02-2003	Keeth et al.	365/189.05
	1	US-6,493,394	12-2002	Tamura et al.	375/257
	J	US-5,046,023	09-1991	Katsura et al.	345/619
	к	US-5,537,555	07-1996	Landry et al.	710/310
	L	US-5,651,138	07-1997	Le et al.	711/154
	М	US-5,717,440	02-1998	Katsura et al.	345/558

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р		WET	NGUYEN		
	Q		PRIMA	NGUYEN RY EXAMINER		
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	·
	٧	
	w	-
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.